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(PTO-1449)

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APPLICANT: **Kenji TOYODA, et al.**	
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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (if known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
HH		US	6,147,922	11/14/2000	Hurst, Jr. et al.	—
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code3 -Number 4 -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
HH		JP 2-3180	01/08/1990	TOSHIBA CORP	—	(Japan w/English Abstract)	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	
HH		Scott TYSON, et al. "Nonvolatile, High Density, High Performance Phase-Change Memory", Aerospace Conference Proceedings, 2000 IEEE Vol. 5, pp. 385-390.	

EXAMINER	DATE CONSIDERED
Huan Huang	9/27/04

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